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 **PALM INTRANET**

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US 20040254424 A1	US- PGPUB	20041216	Integrated panoramic and forward view endoscope	600/176	600/109	Simkulet, Michelle D. et al.
US 20040222210 A1	US- PGPUB	20041111	Multi-zone ceramic heating system and method of manufacture thereof	219/444.1	219/468.1	Lin, Hongy et al.
US 7099086 B2	USPAT	20060829	Wavelength division multiplexing system and method using reconfigurable diffraction grating	359/573	359/569; 359/572; 385/37; 398/84; 398/87	Gutin; Mikhail A.
US 7016462 B1	USPAT	20060321	Ionic pre-concentration XRF identification and analysis device, system and method	378/47	378/45; 378/48	Keville; Robert F. et al.
US 6891791 B1	USPAT	20050510	Optical pickup apparatus and method	369/112.01	369/112.03	Gutin; Mikhail
US 6754614 B1	USPAT	20040622	Linearized static panoramic optical mirror	703/2	348/36; 359/201; 359/725; 703/6; 703/7	Barton; George G. et al.
US 6708132 B1	USPAT	20040316	Microsystems integrated testing and characterization system and method	702/117	324/243; 324/751; 324/765; 700/302; 700/303; 702/115; 702/57; 702/64; 714/735; 714/742; 73/1.41; 73/1.45	Gutierrez; Adolfo O. et al.
US 6671295 B2	USPAT	20031230	Tunable diode laser system, apparatus and method	372/20	372/98; 372/99	Gutin; Mikhail A.
US 6501354 B1	USPAT	20021231	Microelectromechanical liquid metal current carrying system, apparatus and method	335/47	200/193	Gutierrez; Adolfo O. et al.
US 6421179 B1	USPAT	20020716	Wavelength division multiplexing system and method using a reconfigurable diffraction grating	359/572	359/573	Gutin; Mikhail A. et al.
US 6373356 B1	USPAT	20020416	Microelectromechanical liquid metal current carrying system, apparatus and method	335/47	200/233	Gutierrez; Adolfo O. et al.
US 6341526 B1	USPAT	20020129	Micromachined diffractive pressure sensor system	73/705	250/231.19	Castracane; James et al.
US 6341259	USPAT	20020122	Microsystems integrated testing	702/117	367/140;	Gutierrez;

B1			and characterization system and method		702/35; 702/94; 73/514.17	Adolfo O. et al.
US 6282213 B1	USPAT	20010828	Tunable diode laser with fast digital line selection	372/20	372/98; 372/99	Gutin; Mikhail A. et al.
US 6069352 A	USPAT	20000530	Intensity control system for intensified imaging systems	250/214VT	313/524	Castracane; James et al.
US 5999319 A	USPAT	19991207	Reconfigurable compound diffraction grating	359/573	359/572; 359/855	Castracane; James